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**INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION**

(PTO-1449)

ATTY. DOCKET NO.
2336-205

U.S. PATENT
APPLICATION NO.
10/669,328

APPLICANT
Ja Young PARK

FILING DATE
September 25, 2003

GROUP
2681 2616

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	English Abstract	
						Yes	No
NS	2002-261650	13.09.2002	Japan			X	
NS	10-75195	1998.3.17	Japan			Equiv. 5,911,116	
NS	10-276003	13.10.1998	Japan			X	
NS	2002-232320	16.08.2002	Japan			X	
NS	2002-16450	2002.1.18	Japan			Equiv. 2002/0002038 A1	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER	
DATE CONSIDERED	
11/30/07	

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. 2336-205	U.S. PATENT APPLICATION NO. 10/669310	
				APPLICANT Ja Young PARK		
				FILING DATE September 25, 2003	GROUP 2616	
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
NS	5,548,826	08/1996	Sayers			
FOREIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation Yes No
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER				DATE CONSIDERED		
				11/30/07		

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